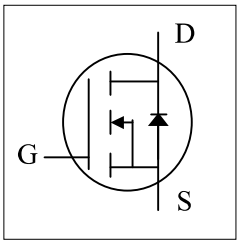
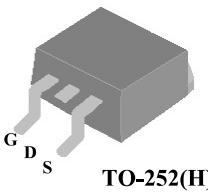
▼ Simple Drive Requirement
▼TO-252 Compatible
▼ Low On-resistance
▼ RoHS Compliant & Halogen-Free



BV_{DSS}	30V
$R_{DS(ON)}$	3.1mΩ
I_D	150A



TO-252(H)

Description

AP150N03K series are from Advanced Power innovated design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.

Absolute Maximum Ratings@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	±20	V
I_D@T_C=25℃	Drain Current (Chip), V_{GS} @ 10V	150	A
I_D@T_A=25℃	Drain Current, V_{GS} @ 10V[3]	100	A
I_D@T_A=70℃	Drain Current, V_{GS} @ 10V[3]	75	A
I_{DM}	Pulsed Drain Current[1]	380	A
P_D@T_C=25℃	Total Power Dissipation	62.5	W
P_D@T_A=25℃	Total Power Dissipation	5	W
T_{STG}	Storage Temperature Range	-55 to 150	℃
T_J	Operating Junction Temperature Range	-55 to 150	℃

Thermal Data

Symbol	Parameter	Value	Units
Rthj-c	Maximum Thermal Resistance, Junction-case	2.5	℃/W
Rthj-a	Maximum Thermal Resistance, Junction-ambient[3]	25	℃/W

Electrical Characteristics@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=250uA	30	-	-	V
$R_{DS(ON)}$	Static Drain-Source On-Resistance[2]	V_{GS}=10V, I_D=50A	-	3.1	3.5	mΩ
		V_{GS}=4.5V, I_D=40A	-	4.3	4.9	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS}, I_D=250uA	1.2	1.45	2	V
g_{fs}	Forward Transconductance	V_{DS}=10V, I_D=30A	-	75	-	S
I_{DSS}	Drain-Source Leakage Current	V_{DS}=24V, V_{GS}=0V	-	-	10	uA
I_{GSS}	Gate-Source Leakage	V_{GS}=±12V, V_{DS}=0V	-	-	±100	nA
Q_g	Total Gate Charge	I_D=20A	-	34	54	nC
Q_{gs}	Gate-Source Charge	V_{DS}=15V	-	8	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	V_{GS}=4.5V	-	18	-	nC
$t_{d(on)}$	Turn-on Delay Time	V_{DS}=15V	-	13	-	ns
t_r	Rise Time	I_D=1A	-	9	-	ns
$t_{d(off)}$	Turn-off Delay Time	R_G=3.3Ω	-	52	-	ns
t_f	Fall Time	V_{GS}=10V	-	20	-	ns
C_{iss}	Input Capacitance	V_{GS}=0V	-	3350	5360	pF
C_{oss}	Output Capacitance	V_{DS}=15V	-	460	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	375	-	pF
R_g	Gate Resistance	f=1.0MHz	-	1.2	2.4	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage[2]	I_S=50A, V_{GS}=0V	-	-	1.2	V
t_{rr}	Reverse Recovery Time	I_S=10A, V_{GS}=0V,	-	32	-	ns
Q_{rr}	Reverse Recovery Charge	dI/dt=100A/μs	-	30	-	nC

Notes:

1.Pulse width limited by Max. junction temperature

2.Pulse test

3.Surface mounted on 1 in^2 copper pad of FR4 board, t ≤10sec

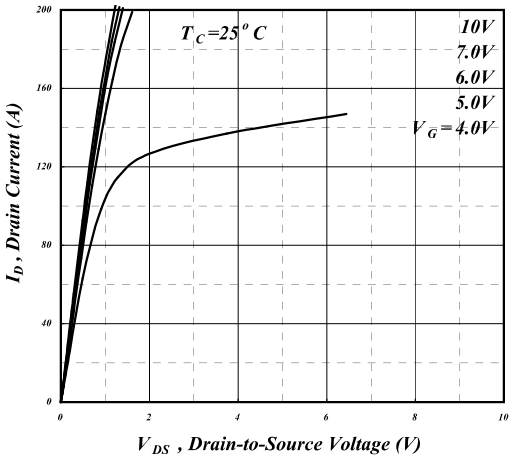


Fig 1. Typical Output Characteristics

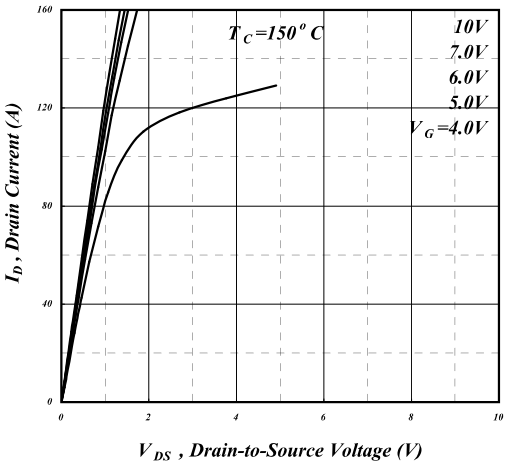


Fig 2. Typical Output Characteristics

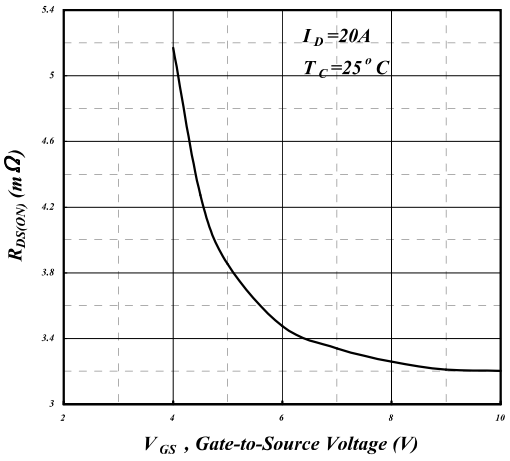


Fig 3. On-Resistance v.s. Gate Voltage

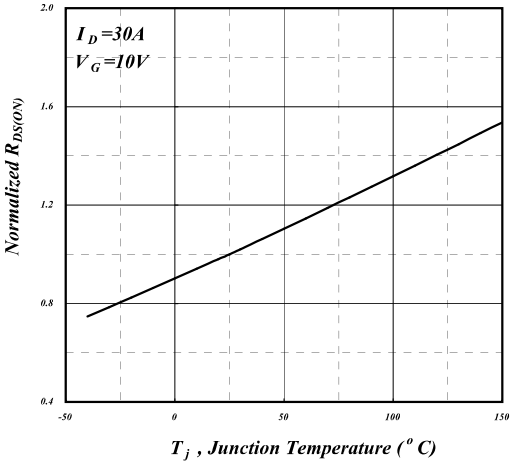


Fig 4. Normalized On-Resistance v.s. Junction Temperature

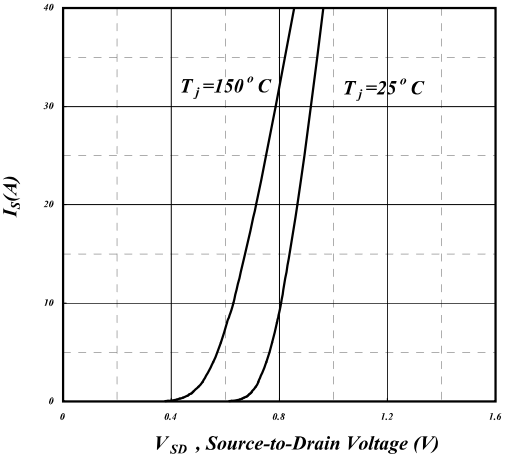


Fig 5. Forward Characteristic of Reverse Diode

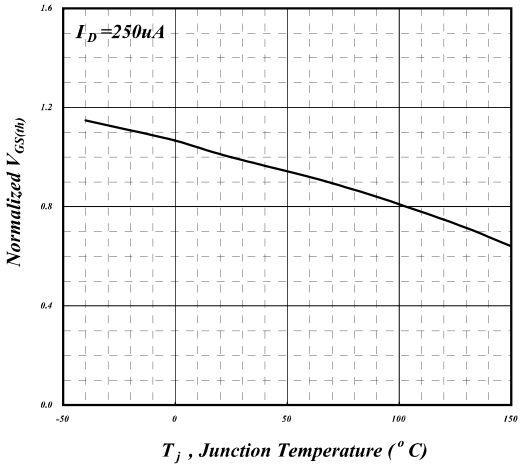


Fig 6. Gate Threshold Voltage v.s. Junction Temperature

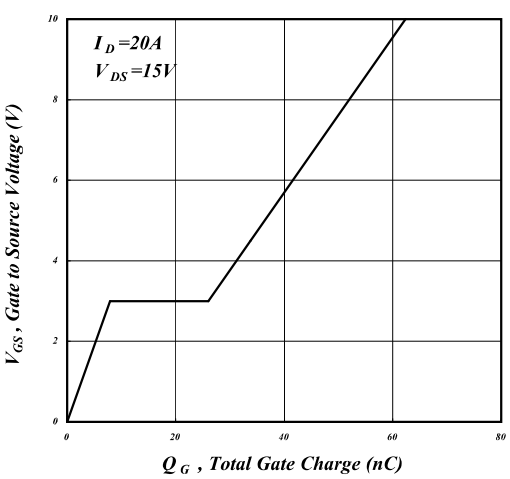


Fig 7. Gate Charge Characteristics

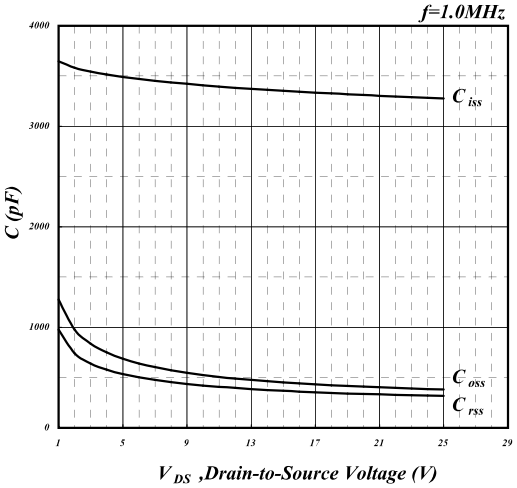


Fig 8. Typical Capacitance Characteristics

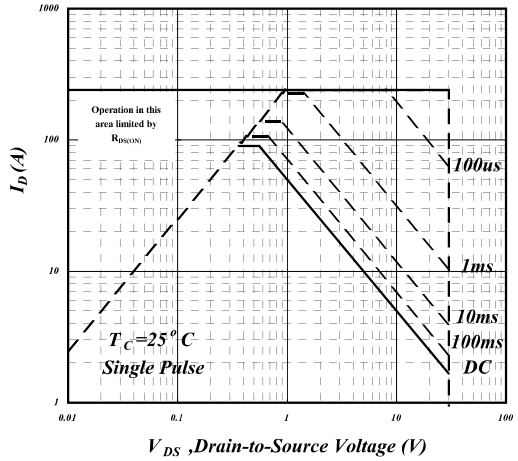


Fig 9. Maximum Safe Operating Area

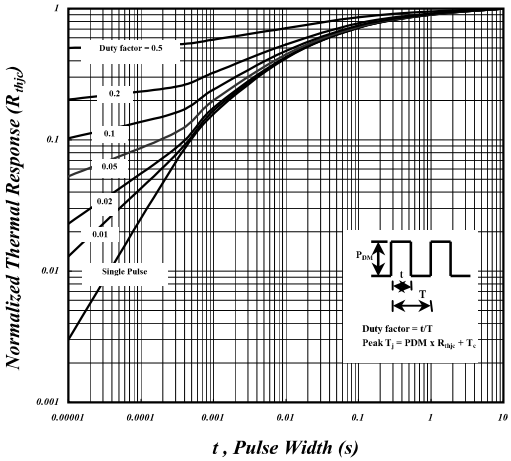


Fig 10. Effective Transient Thermal Impedance

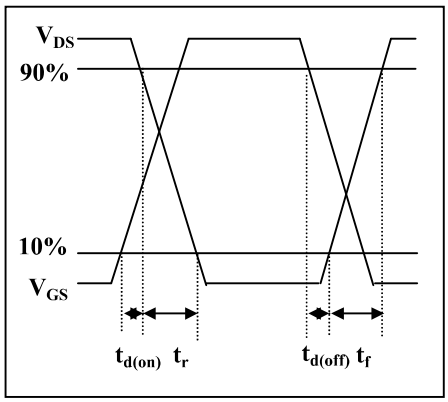


Fig 11. Switching Time Waveform

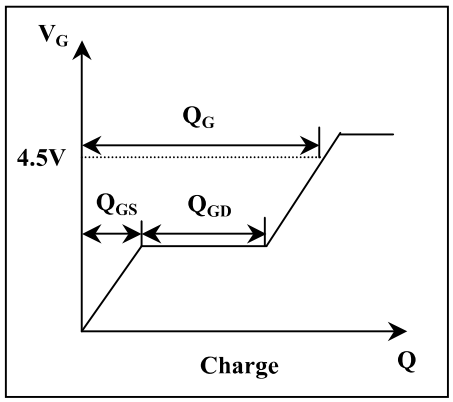


Fig 12. Gate Charge Waveform